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APPLICANTS

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\*\* CONTINUING DATA \*\*\*\*\* NONE OG

\*\* FOREIGN APPLICATIONS \*\*\*\*\* NONE OG

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Verified and Acknowledged	Examiner's Signature <u>OG</u> Initials				

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TITLE

Critical dimension measurement by diffraction

FILING FEE  RECEIVED 876	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees ( Filing ) <input type="checkbox"/> 1.17 Fees ( Processing Ext. of time ) <input type="checkbox"/> 1.18 Fees ( Issue ) <input type="checkbox"/> Other _____
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